

Thermoelectric Power Measurements of Tungsten Diselenide $W_{0.90}Se_2$ Single Crystals

D .K. Patel

Department of Physics, C. U. Shah Science College, Ahmadabad, Gujarat, India

ABSTRACT

The Thermoelectric power (TEP) of semiconductors has been measured as such study can provide information on Free carrier concentration, The See back coefficients, effective mass of holes m_h and scattering mechanism. The thermoelectric power of as grown crystals was measured in the temperature range of 313K to 403K. The positive sign of thermoelectric power depicted their p-type nature within the temperature range studied.

Keywords : Crystal growth, Hall Effect, thermoelectric effect, semiconductor, Seebeck effect

I. INTRODUCTION

The transition metal dichalcogenides WSe_2 are layer compounds consisting of sandwiches with strong covalent/ ionic intralayer bonds and weak Van der Waals interlayer interactions. These MX_2 ($M = W$ and $X = Se$) are of interest for many technological applications. They are suitable for use as high-temperature lubricants, hydrogenation catalysts, and batteries due to weak van der Waals interactions between adjacent layers in the MX_2 lattice [1-2]. The single crystal of WSe_2 grown by Direct vapor transport technique. The structural properties of WSe_2 single crystals have been studied [3-5].

II. EXPERIMENTAL TECHNIQUE

The thermoelectric power measurements for all the samples were carried out in temperature range of 313 K to 403K with the help of thermoelectric power measurements setup. It consists of two blocks: (1) Sample holder with heater and pick up probes and (2) Electronic circuit controlling temperature and temperature gradient across the sample. The sample holder consists of two low power heaters A and B. The temperature T of the heaters A and B are measured by K type thermocouples (TC1 and TC2). The sample under investigation is mounted directly on the heaters, and is held by two pick up probes, which are of copper. These probes also measure the Seebeck voltage developed

across the two ends of the sample. The second block consists of temperature indicator, proportional controller and two-heater control circuit which drive the two heaters A and B. With the help of this electronic control circuit it is possible to generate a stable temperature gradient between the two heaters. It is possible to control the temperature from 298 K to 573 K with ΔT of ± 5 K simultaneously with better than ± 1 K stability. The problems usually encountered in making thermoelectric power measurement are stray thermal emf. The sample and the electronic circuit have been incorporated into one unit. Use of low power heaters and electronic controllers makes the operation very easy and Seebeck coefficient of the sample can be measured very conveniently.

III. RESULT AND DISCUSSION

The measurement of thermoelectric power as a function of temperature is one of the important method for investigating electronic properties of solids. The thermoelectric power (S) provides useful information about the mechanism of electrical transport. As pointed out the quantity S can be used to determine the mobility ratio, the concentration of carriers, the position of Fermi level etc. in addition, the sign of S indicated the type of dominant carriers or the type of dominant electronic conduction. For the study of temperature dependent thermoelectric power ' S ' of a p type Semiconductor the following expression [6] can be used.

$$S = \frac{k}{e} \left[A + \frac{EF}{kT} \right] \quad (1)$$

Where k is Boltzman constant, e is the electronic charge, A is the constant determined by the dominant scattering process and EF is the separation of the Fermi level from the top of the valance band.

Table 1. Result of Thermo-electric Power Measurement

Sample: $W_{0.90}Se_2$ Thickness $t = 0.002\text{cm}$ $\Delta T = 5\text{K}$

Temp T K	$\frac{1}{T} \times 10^{-3}$ k ⁻¹	Voltage mV	S= $\frac{\mu V}{K}$
313	3.19	2.10	420
318	3.14	2.00	400
323	3.09	1.95	390
328	3.04	1.90	380
333	3.00	1.85	370
338	2.95	1.80	360
343	2.91	1.72	344
348	2.84	1.70	340
353	2.83	1.65	330
358	2.79	1.62	324
363	2.75	1.60	320
368	2.71	1.54	308
373	2.68	1.40	280
378	2.64	1.35	270
383	2.61	1.32	264
388	2.57	1.27	254
393	2.54	1.25	250
398	2.51	1.20	240
403	2.48	1.05	210

For a small temperature range, EF is fairly constant and hence if the thermoelectric power (TEP) is plotted against the temperature, a straight line is expected. Figure 1 shows the variation of TEP with an inverse of temperature for WSe_2 single crystal. The values of EF and A were determined from the slope and intercept respectively, and listed in Table 1 for each samples. The values of constant 'A' is given

$$A = \frac{5}{2} - S \quad (2)$$

where 's' is the scattering parameter. Revolinsky and Beernsten express the thermoelectric power,

$$S = \frac{k}{e} \left[A + \ln \frac{NA}{\rho} \right] \quad (3)$$

Where NA is the effective density of states and d is given by

$$NA = 2 \left[\frac{2\pi m_e^* kT}{h^3} \right] \quad (4)$$

Where m_e^* is the effective mass of electrons. Using the values of carrier concentration obtained from the Hall Effect measurement, the effective density of state NA for the as grown crystals can be calculated with the help of the formula

$$P = N_A \exp(-EF/kT) \quad (5)$$

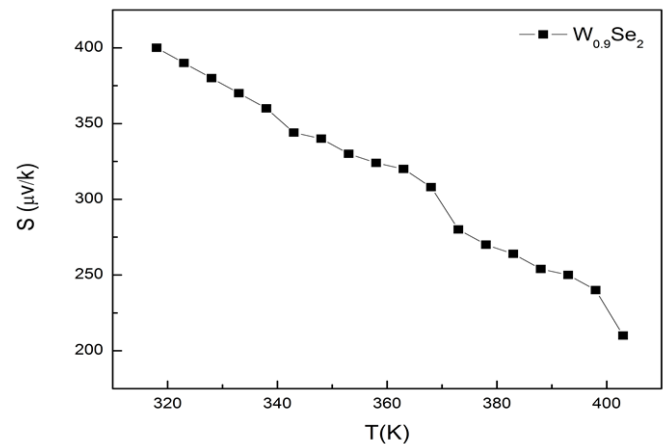


Figure 1. The variation of thermoelectric power with T for $W_{0.90}Se_2$ single crystals

Table1: The Values Of The Seebeck Parameters For $W_{0.90}Se_2$ Single Crystals

Parameters	Obtained Values
A	1.16
Scattering parameter 's'	1.34
Fermi energy 'EF' (eV)	0.028
Effective mass of electron m_h^* (mh)	$0.0162 \times 10^{-35} \text{kg}$.
Effective density of state 'Nc' (cm^{-3})	7.65×10^{16}

Where EF is the Fermi energy at room temperature. The values of effective density of state thus obtained for as grown crystals. Using this value of effective density of

state, the effective mass of electron for WSe₂ single crystal was calculated.

IV. CONCLUSION

The positive sign of Hall co-efficient reveals that grown crystal is p-type in nature and majority charge carriers in it is holes, which confirms the nature obtained by TEP measurement. It is seen that in all cases thermoelectric power increases linearly with increasing temperature confirming the typical semiconducting behavior of all crystals. The variation of thermoelectric power with temperature shows that the charge impurity scattering predominates in Tungsten diselenide single crystals.

V. REFERENCES

- [1]. J Cheon, JE Gozum and GS Girolami (1997), Chemistry of Materials 9(8) 1847.
- [2]. Lewkebandara TS and Winter CH (1994). Advanced Materials 6(3) 237.
- [3]. Dave MS, Patel KR and Vaidya Rajiv (2012). International Journal of Physics and Mathematical Sciences 2(3) 1-5.
- [4]. Vaidya Rajiv, Dave Mehul, Patel SG and Jani AR (2005). Indian Journal of Physics 79(1) 85-87.
- [5]. Kaushik R. Patel and Duhita Lakhataria, (2016). International Journal of Physics and Mathematical Sciences 6(1) 11-16.
- [6]. K P Mohanchandra and J Uchil, 1997, Thin Solid Films, 305 124.